

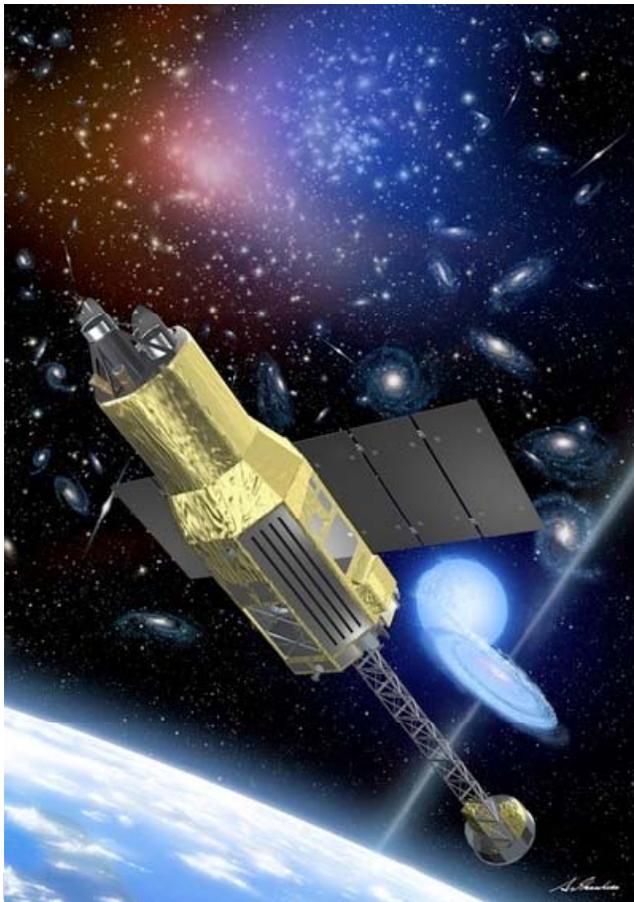


Development of the Soft Gamma-ray Detector on board ASTRO-H

ASTRO-H 衛星搭載軟ガンマ線検出器の開発(2012年度後半)

Mar 27, 2013

Hiroshima, JPS meeting



T. Mizuno, H. Tajima^A, Y. Fukazawa, S. Watanabe^{B,C}, H. Uchiyama^C, Y. Uchiyama^D, T. Enoto^E, M. Ohta^B, M. Ohno, H. Odaka^B, J. Kataoka^F, M. Kawaharada^B, M. Kokubun^B, G. Sato^B, R. Sato^B, T. Takahashi^{B,C}, H. Takahashi, S. Takeda^B, S. Tashiro^G, T. Tanaka^H, Y. Terada^G, K. Nakazawa^C, K. Nakamori^F, R. Brandford^D, K. Makishima^C, G. Madejski^D, K. Mori^B, Y. Yatsu^I, S. Yamada^E, T. Yuasa^B, D. Yonetoku^J, P. Laurent^K, O. Limousin^K, F. Lebrun^K and the SGD team

広島大学, 名大STE研^A, ISAS/JAXA^B, 東大理^C, KIPAC/Stanford^D, 理研^E, 早大理工^F, 埼大理^G, 京大理^H, 東工大理^I, 金沢大自^J, CEA-DSM-IRFU^K



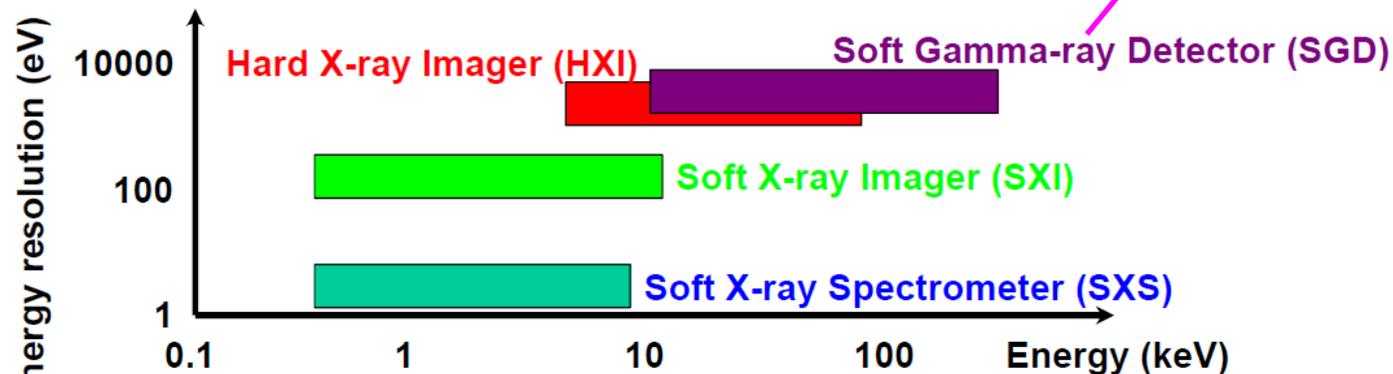
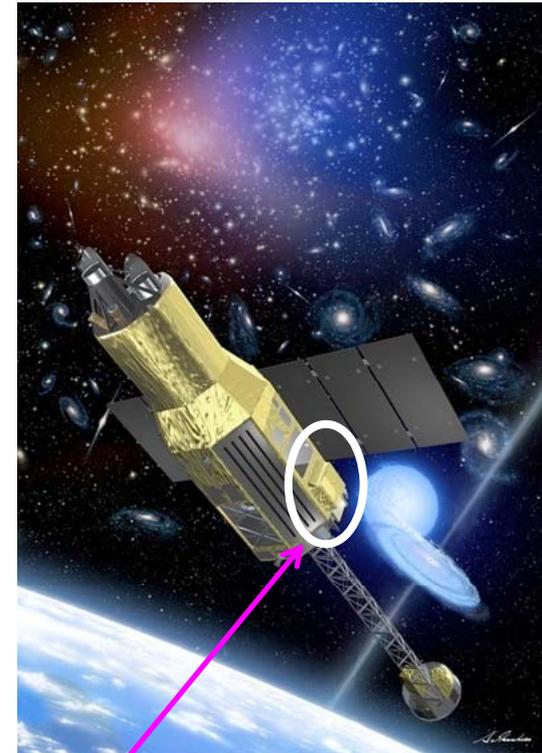
ASTRO-H & SGD

Objectives of ASTRO-H (#3)

- The most sensitive wideband observation over an energy range from 0.3 to 600 keV

Soft Gamma-ray Detector(SGD)

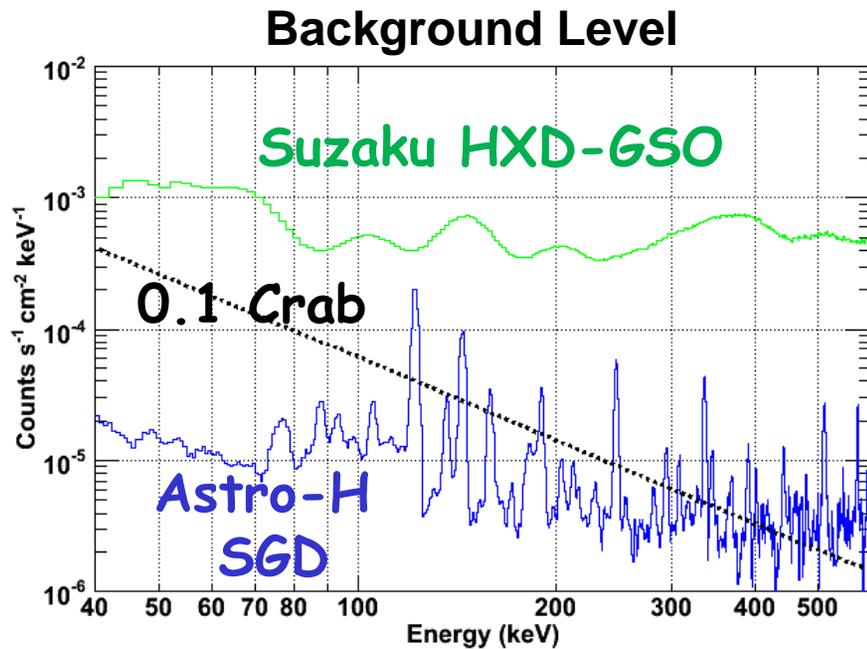
- Highly-sensitive observation in 60-600 keV
 - narrow-FOV Compton Camera
 - extremely-low background





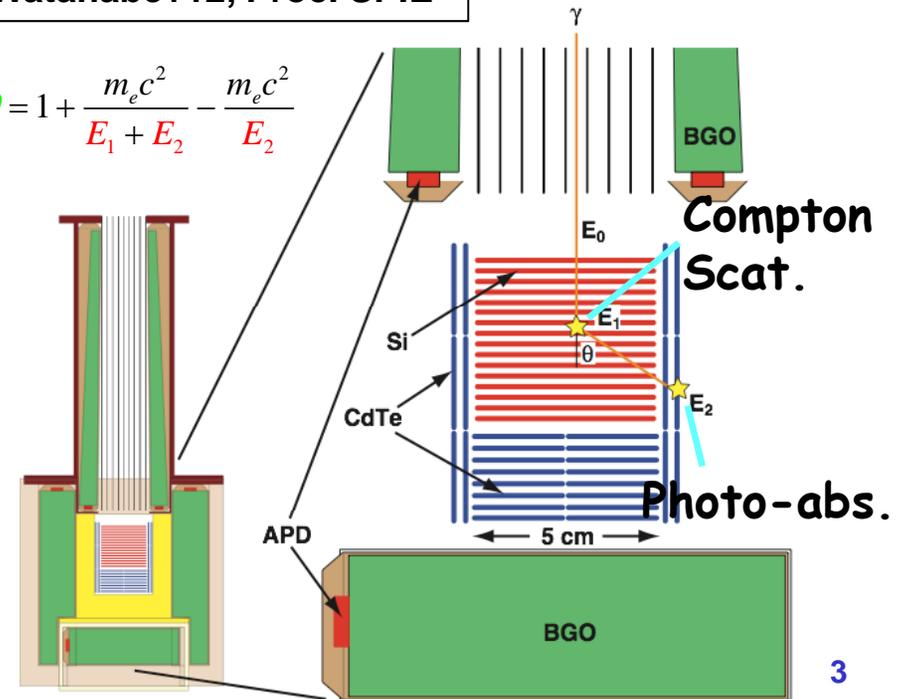
SGD Concept

- **Si-CdTe Compton Camera + BGO shielded**
- **Constrain incident angle using Compton kinematics**
 - **efficient background suppression**
 - **extra success: soft gamma-ray polarimetry**



Tajima+ 10, Proc. SPIE
Watanabe+12, Proc. SPIE

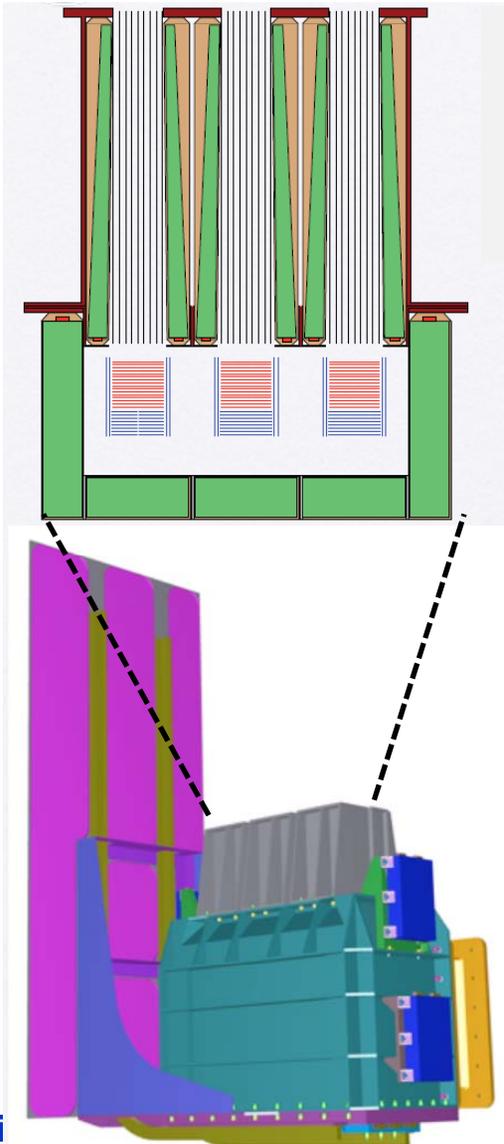
$$\cos \theta = 1 + \frac{m_e c^2}{E_1 + E_2} - \frac{m_e c^2}{E_2}$$



T. Mizuno et al. $BG \leq 100 \text{ mCrab}$



SGD System



- **Two SGD on Astro-H**
 - **Compton Camera**
 - **BGO Active Shield**
 - 10 deg FOV
 - 25 modules
 - read-out by APD
 - **Fine Collimator**
 - 0.5 deg FOV ($E \leq 150$ keV)
 - reduce CXB/source confusion
 - **Housing**
 - **Cooling System**
 - keep CC/APD at $-15 \sim -20$ °C
 - heat pipe, radiator
- **SGD-AE**

SGD-S



Development in the second half of this fiscal year

(updates since 2012 Sep. JPS meeting, 14aSP-9)

- **SGD-S**
 - (done as of 2012 Sep.) vibration test (issue found), thermal balance test
 - **radiator support structure improvement, acoustic test, vibration test (scheduled on 2013 Mar.)**
- **Compton Camera**
 - (done as of 2012 Sep.) test of partial EM
 - **construction of full-EM, electric test, thermal-vacuum test, vibration test (scheduled on 2013 Mar.)**
- **BGO, APD**
 - **new method of gluing APD and BGO developed and tested**
 - **verification of signal processing firmware**
- **Fine Collimator**
 - **acceptance test preparation**
- **Other**
 - **internal release of the MDP (sensitivity of pol. measurement) calculation tool**



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 - verification of signal processing firmware **Tokuda+, 27pBE-6**
- **Fine Collimator**
 - acceptance test preparation **Kimura+, 27pBE-9**
- **Other**
 - **internal release of the MDP (sensitivity of pol. measurement) calculation tool**

Ohta+, 27pBE-11



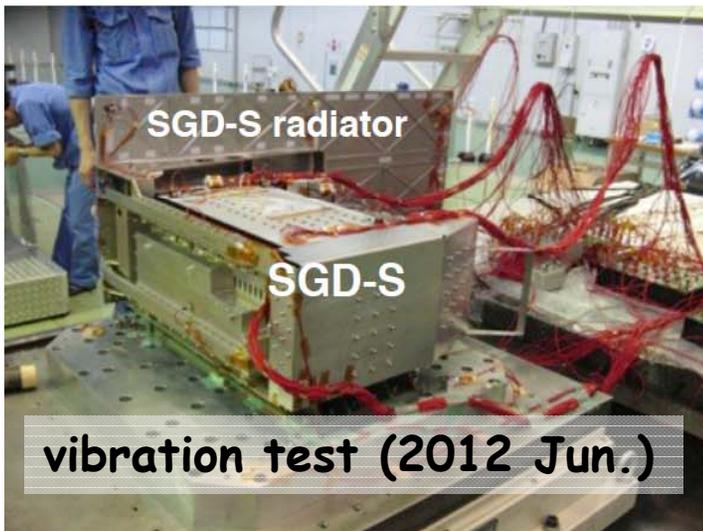
EM Test Status of SGD-S

(Ohta, Watanabe, Nakazawa, Noda, Ichinohe, MHI)

- **Vibration test**
 - issue found in radiator support
 - improvement of the structure verified by an analysis. test scheduled on Mar. (see next)
- Thermal-balance test: confirmation of thermal design
- Acoustic test: no apparent damage. effects on FC evaluated

Ohta+, 27pBE-11

Kimura+, 27pBE-9

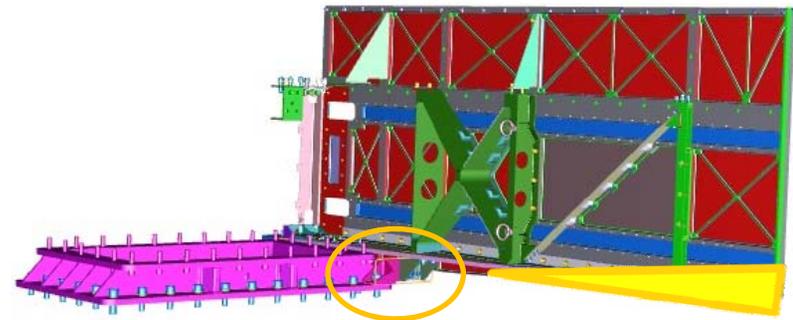




Radiator Support Structure

(Nakazawa, Ohta, Minesugi, Ishimura, MHI)

- Issue found during SGD-S EM vibration test
 - radiator structure had a high Q-value(>100) and low frequency (18, 34... Hz)
 - deformation of the radiator plate
 - risk of hitting against the satellite side panel
- Improved radiator support structure
 - rigidity increase of radiator and back-structure. cut the panel edge
 - addition of Ti-support plate between radiator and interface plate
 - strengthen housing bottom structure
- Results by and analysis (@Q=50)
 - higher resonance freq. (18 Hz->40 Hz, 34 Hz->59 Hz)
 - displacement: 24 mm < 64 mm (allowance)
- V-test scheduled on Mar. to confirm the design

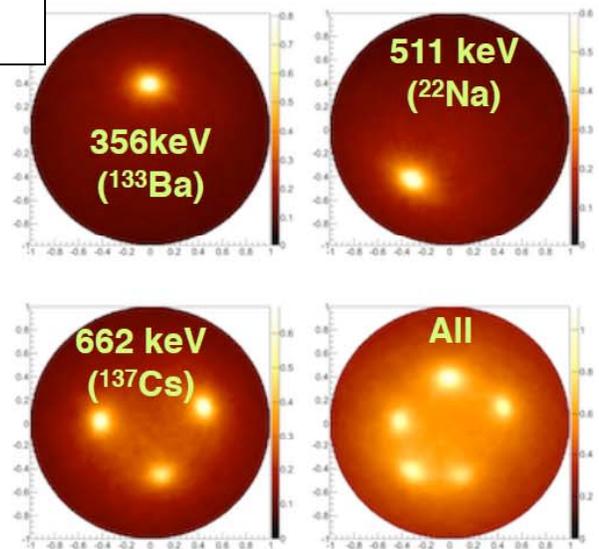
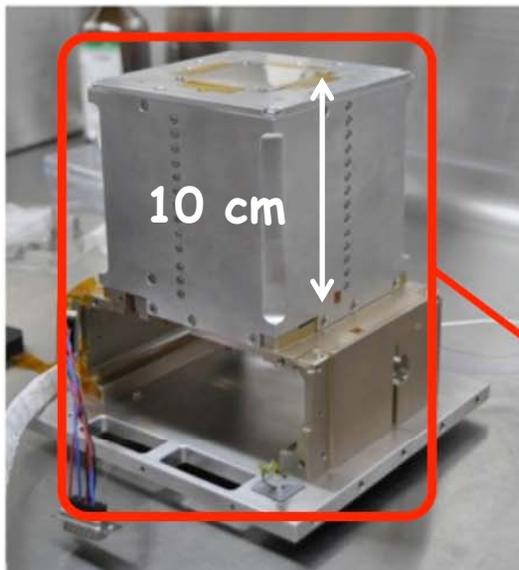




Full EM Compton Camera Electric Test

(Ichinohe, Takeda, Watanabe, Togo)

- Configuration of full EM Compton Camera
 - sensor module is the same as FM in terms of design and material
 - FPGA, some PCBs and passive parts are not space qualified
- Fully functional except for one out of 8 side-CdTe modules
 - fraction of bad channels (noisy, disconnected)
 - Si: ~0.03%, CdTe: ~2%
 - no degradation of energy resolution
- Verification of imaging capability with Compton kinematics

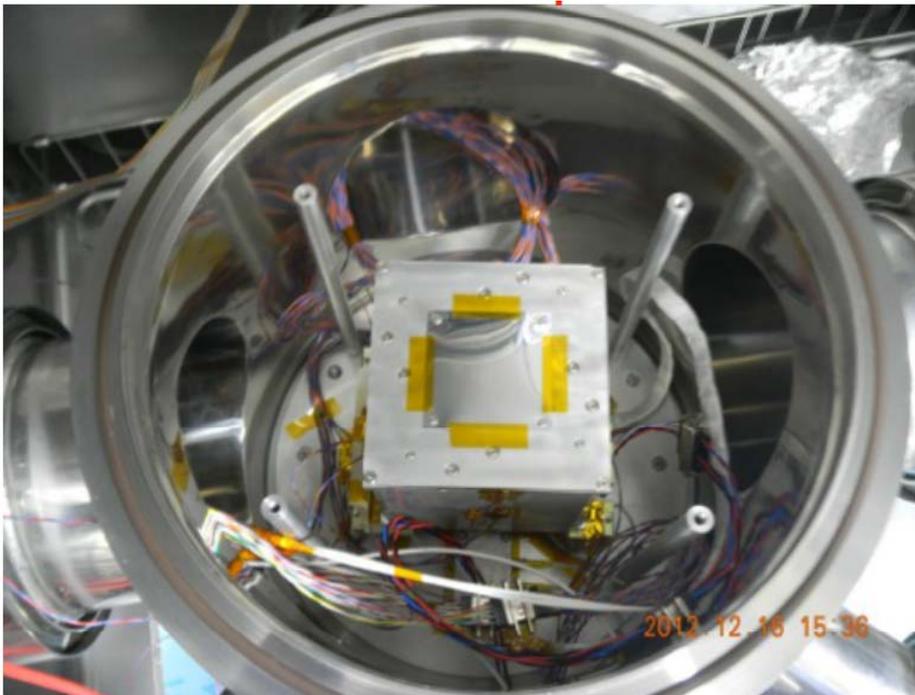




EM CC Thermal Vacuum Test

(Watanabe, Takeda, Nakamura, Furui)

- **Thermal vacuum test in 2012 Dec. 14-28**
 - verification of thermal design and energy resolution in vacuum
 - continuous operation for several days

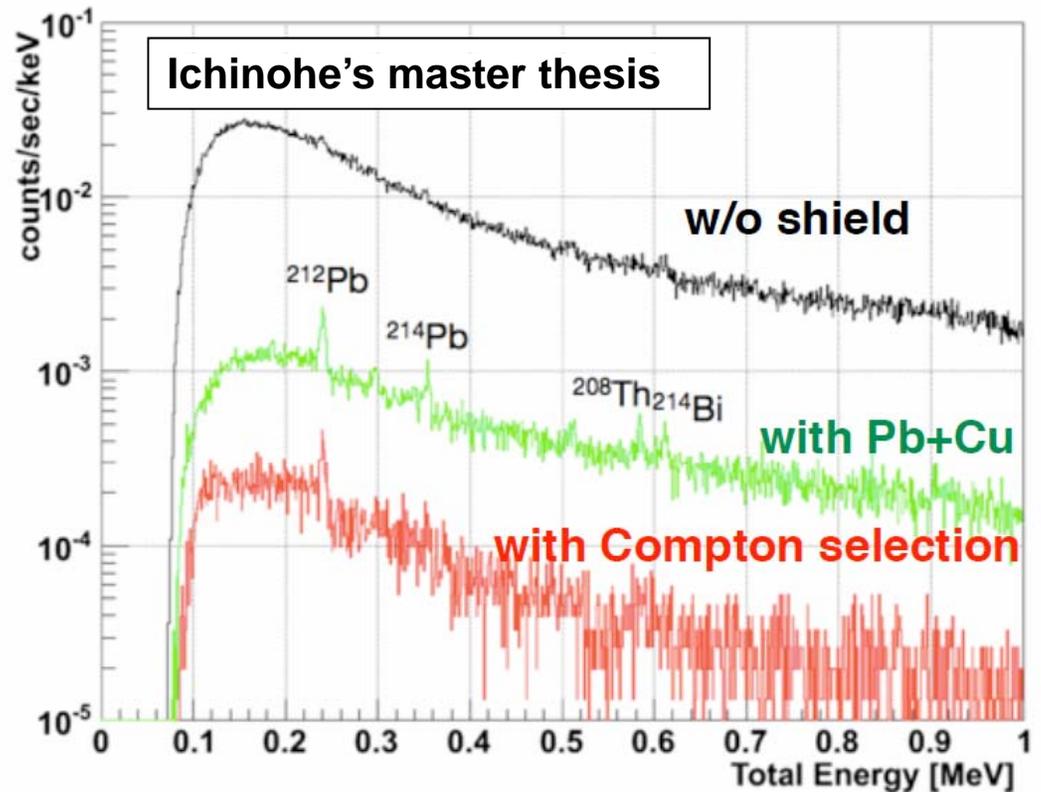
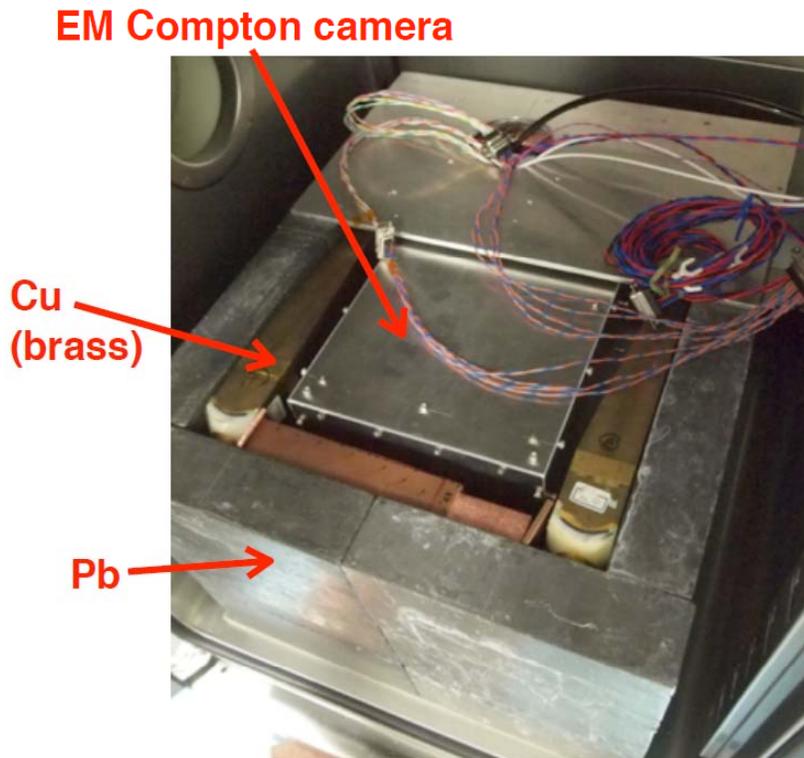




EM CC Internal Background

(Ichinohe, Takeda, Watanabe, Togo)

- **Verification of internal background level**
 - place Compton Camera inside passive shield (Pb+Cu)
 - no prominent radio isotope found

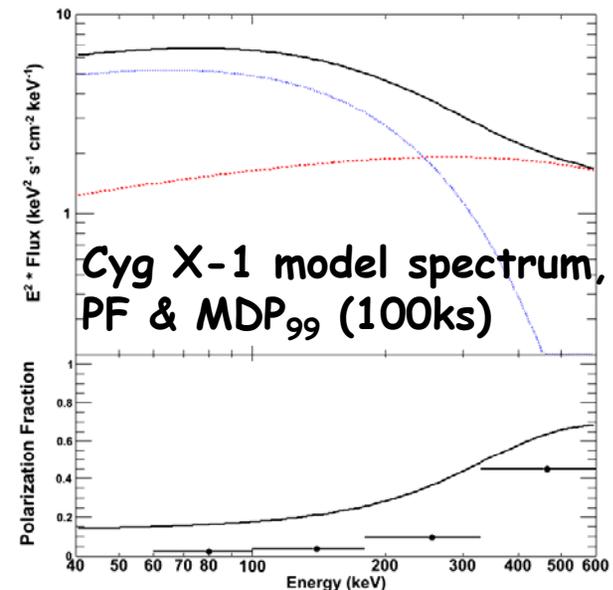
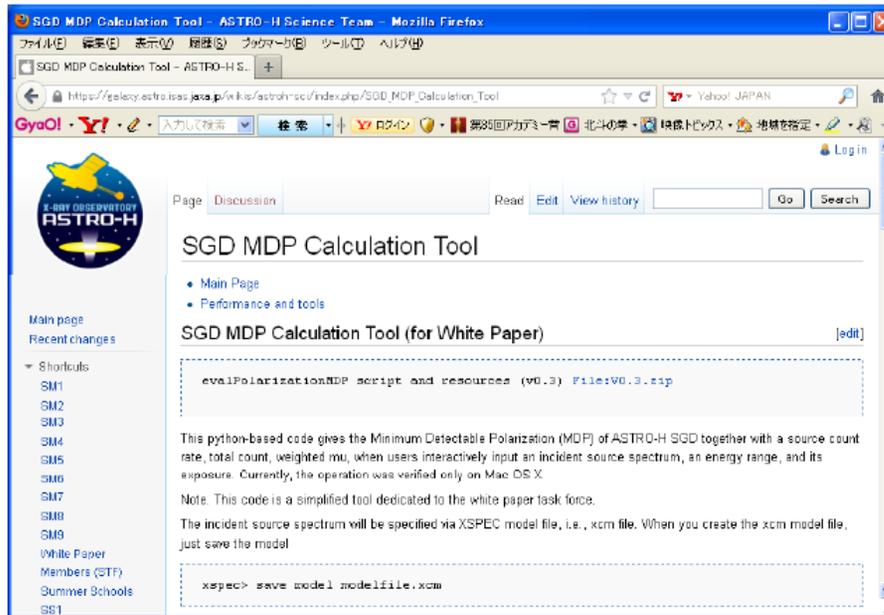
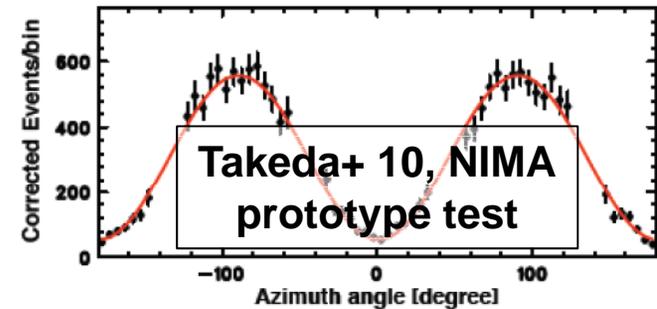




MDP Calculation Tool

- SGD is a highly-sensitive spectrometer and polarimeter
- Internally release of a flexible tool to calculate MDP for user-defined spectrum and energy range (available in ASTRO-H Science Page)

(Enoto and SGD team)





Summary

- **SGD-S**
 - vibration test, thermal balance test and acoustic test performed
 - issues on radiator structure being resolved and verified
- **Compton Camera**
 - 1st full EM constructed
 - electric and thermal vacuum test performed
 - internal background measured w/ passive shield
- **Preparation of each component**
 - FC, BGO, APD (method of gluing developed and tested)
- **Internal release of MDP evaluation tool**

Thank you for your Attention

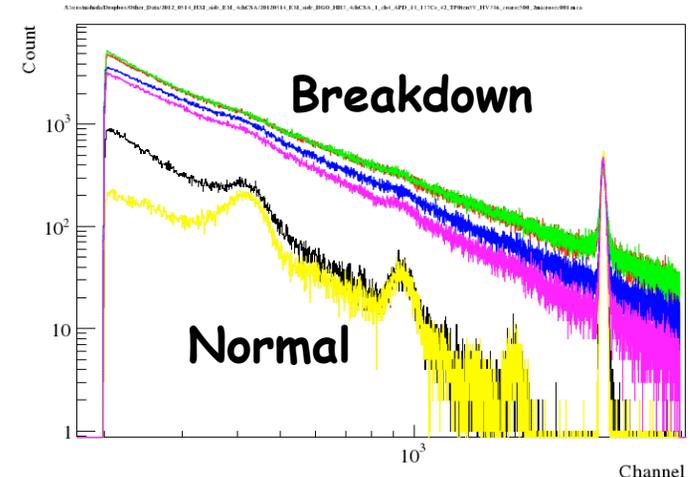
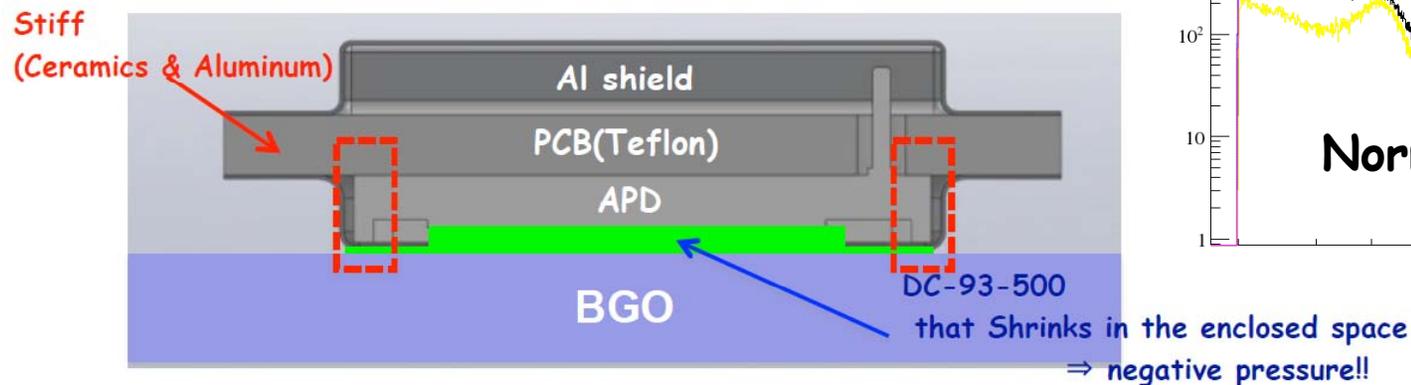


Backup Slides



APD-BGO Assembly Issues

- I-V breakdown of APDs
 - likely to be caused by cure induced shrinkage of DC-93-500 elastic adhesive (negative pressure)
- Gluing of BGO and APD
 - separation of glue at low temperature
 - caused by shrinkage of DC-93-500 at low temperature

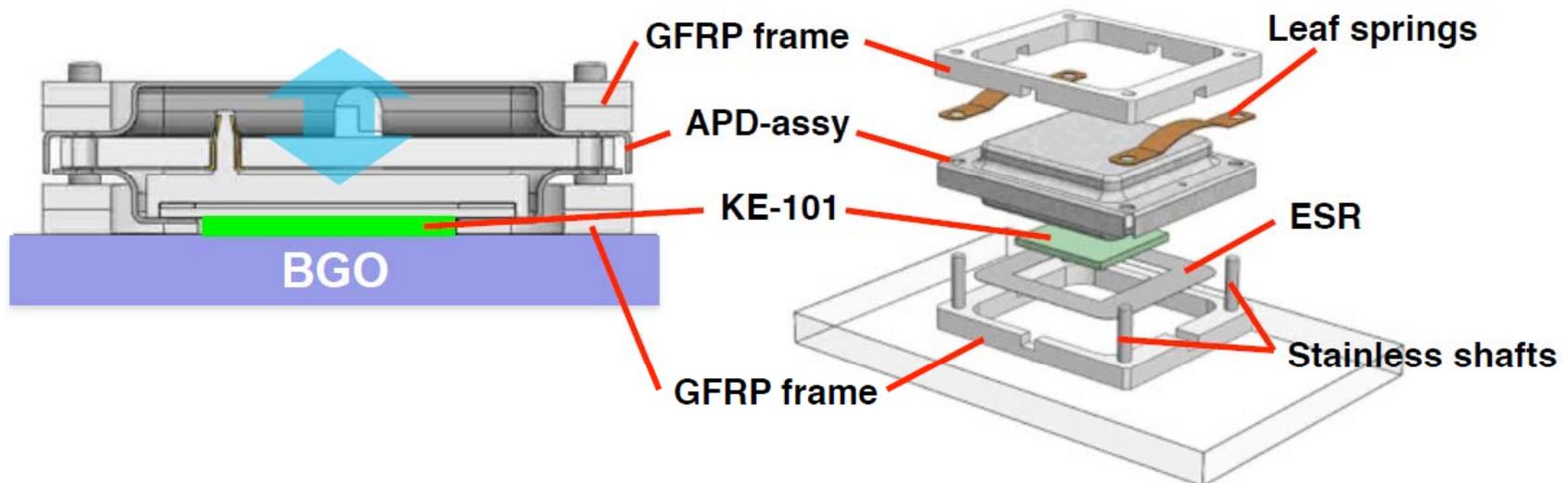




Solution for APD-BGO Assembly Issues

(Nakazawa, Sasano, Yatsu, Saito, Sato, Nakamori, Kataoka)

- DC-93-500 => KE-101 (smaller cure induced shrinkage)
- New structures for releasing the negative stress
 - prototype passed
 - adhesive tests, vibration tests (QT+3dB), shock tests (QT), thermal cycle tests (-35~-40 °C), low-temperature vacuum tests (-35°C) , electrical tests of APD (no breakdown)





FM Fabrication, Test and Delivery Schedule

